

Search Notes

Application/Control No.

10/811,132

Examiner

David E. Bochna

Applicant(s)/Patent under
Reexamination

MATT ET AL.

Art Unit

3679

SEARCHED

Class	Subclass	Date	Examiner
285	414	3/5/2006	DB
	368		
	412		
	374		
	901		

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR